

<b>Issue Classification</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	09/378,217	PHILYAW ET AL.
	Examiner Chau Nguyen	Art Unit 2176

ISSUE CLASSIFICATION			
ORIGINAL		CROSS REFERENCE(S)	
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)
709	219	709	217 218 219 203 224 226 227
INTERNATIONAL CLASSIFICATION		709	229 231 238 245
G 0 6 F	15/16	725	105 109 112
G 0 6 F	15/173	707	10 104.1
H 0 4 N	7/173		
G 0 6 F	7/00		
G 0 6 F	17/30		
<i>Chau Nguyen</i> 1/11/2006 (Assistant Examiner) (Date)		<i>Heather Herndon</i> HEATHER R. HERNDON SUPERVISORY PATENT EXAMINER TECHNOLOGY CENTER 2100 (Primary Examiner) (Date) <i>12-18-06</i>	
(Legal Instruments Examiner) (Date)		Total Claims Allowed: 10 O.G. Print Claim(s) 1 O.G. Print Fig. 6	

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
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